Measuring Sample Quality with Kernels

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June 25, 2018

Motivation: Large-scale Posterior Inference

Example: Bayesian logistic regression

- **()** Fixed covariate vector: $v_l \in \mathbb{R}^d$ for each datapoint $l = 1, \ldots, L$
- **2** Unknown parameter vector: $\beta \sim \mathcal{N}(0, I)$
- **3** Binary class label: $Y_l \mid v_l, \beta \stackrel{\text{ind}}{\sim} \text{Ber}\left(\frac{1}{1+e^{-\langle \beta, v_l \rangle}}\right)$
 - Generative model simple to express
 - Posterior distribution over unknown parameters is complex
 - Normalization constant unknown, exact integration intractable

Standard inferential approach: Use Markov chain Monte Carlo (MCMC) to (eventually) draw samples from the posterior distribution

- **Benefit:** Approximates intractable posterior expectations $\mathbb{E}_{P}[h(Z)] = \int_{\mathcal{X}} p(x)h(x)dx$ with asymptotically exact sample estimates $\mathbb{E}_{Q}[h(X)] = \frac{1}{n} \sum_{i=1}^{n} h(x_{i})$
- **Problem:** Each new MCMC sample point x_i requires iterating over entire observed dataset: prohibitive when dataset is large!

Motivation: Large-scale Posterior Inference

Question: How do we scale Markov chain Monte Carlo (MCMC) posterior inference to massive datasets?

- MCMC Benefit: Approximates intractable posterior expectations $\mathbb{E}_{P}[h(Z)] = \int_{\mathcal{X}} p(x)h(x)dx$ with asymptotically exact sample estimates $\mathbb{E}_{Q}[h(X)] = \frac{1}{n} \sum_{i=1}^{n} h(x_{i})$
- **Problem:** Each point x_i requires iterating over entire dataset!

Template solution: Approximate MCMC with subset posteriors

[Welling and Teh, 2011, Ahn, Korattikara, and Welling, 2012, Korattikara, Chen, and Welling, 2014]

- Approximate standard MCMC procedure in a manner that makes use of only a small subset of datapoints per sample
- Reduced computational overhead leads to faster sampling and reduced Monte Carlo variance
- Introduces asymptotic bias: target distribution is not stationary
- Hope that for fixed amount of sampling time, variance reduction will outweigh bias introduced

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Motivation: Large-scale Posterior Inference

Template solution: Approximate MCMC with subset posteriors

[Welling and Teh, 2011, Ahn, Korattikara, and Welling, 2012, Korattikara, Chen, and Welling, 2014]

• Hope that for fixed amount of sampling time, variance reduction will outweigh bias introduced

Introduces new challenges

- How do we compare and evaluate samples from approximate MCMC procedures?
- How do we select samplers and their tuning parameters?
- How do we quantify the bias-variance trade-off explicitly?

Difficulty: Standard evaluation criteria like effective sample size, trace plots, and variance diagnostics assume convergence to the target distribution and do not account for asymptotic bias

This talk: Introduce new quality measures suitable for comparing the quality of approximate MCMC samples

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Kernel Stein Discrepancy

Quality Measures for Samples

Challenge: Develop measure suitable for comparing the quality of *any* two samples approximating a common target distribution

Given

- Continuous target distribution P with support $\mathcal{X} = \mathbb{R}^d$ and density p
 - p known up to normalization, integration under P is intractable
- Sample points $x_1, \ldots, x_n \in \mathcal{X}$
 - Define **discrete distribution** Q_n with, for any function h, $\mathbb{E}_{Q_n}[h(X)] = \frac{1}{n} \sum_{i=1}^n h(x_i)$ used to approximate $\mathbb{E}_P[h(Z)]$
 - ${\scriptstyle \bullet }$ We make no assumption about the provenance of the x_i
- **Goal:** Quantify how well \mathbb{E}_{Q_n} approximates \mathbb{E}_P in a manner that
 - I. Detects when a sample sequence is converging to the target
 - II. Detects when a sample sequence is not converging to the target
 - III. Is computationally feasible

Integral Probability Metrics

Goal: Quantify how well \mathbb{E}_{Q_n} approximates \mathbb{E}_P

- Idea: Consider an integral probability metric (IPM) [Müller, 1997] $d_{\mathcal{H}}(Q_n, P) = \sup_{h \in \mathcal{H}} |\mathbb{E}_{Q_n}[h(X)] - \mathbb{E}_P[h(Z)]|$
 - Measures maximum discrepancy between sample and target expectations over a class of real-valued test functions ${\cal H}$
 - When H sufficiently large, convergence of d_H(Q_n, P) to zero implies (Q_n)_{n≥1} converges weakly to P (Requirement II)

Examples

• Bounded Lipschitz (or Dudley) metric, $d_{BL_{\parallel,\parallel}}$

 $(\mathcal{H} = BL_{\|\cdot\|} \triangleq \{h : \sup_{x} |h(x)| + \sup_{x \neq y} \frac{|h(x) - h(y)|}{\|x - y\|} \le 1\})$

• Wasserstein (or Kantorovich-Rubenstein) distance, $d_{\mathcal{W}_{\|\cdot\|}}$ $(\mathcal{H} = \mathcal{W}_{\|\cdot\|} \triangleq \{h : \sup_{x \neq y} \frac{|h(x) - h(y)|}{\|x - y\|} \leq 1\})$

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 - When H sufficiently large, convergence of d_H(Q_n, P) to zero implies (Q_n)_{n≥1} converges weakly to P (Requirement II)

Problem: Integration under *P* intractable!

 \Rightarrow Most IPMs cannot be computed in practice

Idea: Only consider functions with $\mathbb{E}_P[h(Z)]$ known *a priori* to be 0

- Then IPM computation only depends on $Q_n!$
- How do we select this class of test functions?
- Will the resulting discrepancy measure track sample sequence convergence (Requirements I and II)?
- How do we solve the resulting optimization problem in practice?
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Stein's Method

Stein's method [1972] provides a recipe for controlling convergence:

• Identify operator \mathcal{T} and set \mathcal{G} of functions $g : \mathcal{X} \to \mathbb{R}^d$ with $\mathbb{E}_P[(\mathcal{T}g)(Z)] = 0$ for all $g \in \mathcal{G}$.

 \mathcal{T} and \mathcal{G} together define the **Stein discrepancy** [Gorham and Mackey, 2015] $\mathcal{S}(Q_n, \mathcal{T}, \mathcal{G}) \triangleq \sup_{g \in \mathcal{G}} |\mathbb{E}_{Q_n}[(\mathcal{T}g)(X)]| = d_{\mathcal{T}\mathcal{G}}(Q_n, P),$

an IPM-type measure with no explicit integration under ${\it P}$

- ② Lower bound $S(Q_n, T, G)$ by reference IPM $d_H(Q_n, P)$ ⇒ $S(Q_n, T, G) \rightarrow 0$ only if $(Q_n)_{n \geq 1}$ converges to P (Req. II)
 - Performed once, in advance, for large classes of distributions
- **Output** Upper bound $S(Q_n, T, G)$ by any means necessary to demonstrate convergence to 0 (Requirement I)

Standard use: As analytical tool to prove convergence **Our goal:** Develop Stein discrepancy into practical quality measure

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Identifying a Stein Operator ${\mathcal T}$

Goal: Identify operator \mathcal{T} for which $\mathbb{E}_P[(\mathcal{T}g)(Z)] = 0$ for all $g \in \mathcal{G}$

Approach: Generator method of Barbour [1988, 1990], Götze [1991]

- Identify a Markov process $(Z_t)_{t\geq 0}$ with stationary distribution P
- Under mild conditions, its infinitesimal generator

 $(\mathcal{A}u)(x) = \lim_{t \to 0} \left(\mathbb{E}[u(Z_t) \mid Z_0 = x] - u(x) \right)/t$ satisfies $\mathbb{E}_P[(\mathcal{A}u)(Z)] = 0$

Overdamped Langevin diffusion: $dZ_t = \frac{1}{2} \nabla \log p(Z_t) dt + dW_t$

- Generator: $(\mathcal{A}_P u)(x) = \frac{1}{2} \langle \nabla u(x), \nabla \log p(x) \rangle + \frac{1}{2} \langle \nabla, \nabla u(x) \rangle$
- Stein operator: $(\mathcal{T}_P g)(x) \triangleq \langle g(x), \nabla \log p(x) \rangle + \langle \nabla, g(x) \rangle$ [Gorham and Mackey, 2015, Oates, Girolami, and Chopin, 2016]
 - Depends on P only through $\nabla \log p$; computable even if p cannot be normalized!
 - Multivariate generalization of density method operator $(\mathcal{T}g)(x)=g(x)\frac{d}{dx}\log p(x)+g'(x)$ [Stein, Diaconis, Holmes, and Reinert, 2004]

Goal: Identify set \mathcal{G} for which $\mathbb{E}_P[(\mathcal{T}_P g)(Z)] = 0$ for all $g \in \mathcal{G}$

Approach: Reproducing kernels $k : \mathcal{X} \times \mathcal{X} \to \mathbb{R}$

- A reproducing kernel k is symmetric (k(x, y) = k(y, x)) and positive semidefinite $(\sum_{i,l} c_i c_l k(z_i, z_l) \ge 0, \forall z_i \in \mathcal{X}, c_i \in \mathbb{R})$
 - Gaussian kernel $k(x,y) = e^{-\frac{1}{2}||x-y||_2^2}$
 - Inverse multiquadric kernel $k(x,y) = (1 + ||x y||_2^2)^{-1/2}$
- Generates a reproducing kernel Hilbert space (RKHS) \mathcal{K}_k
- We define the kernel Stein set $\mathcal{G}_{k,\|\cdot\|}$ as vector-valued g with
 - Each component g_j in \mathcal{K}_k
 - Component norms $\|g_j\|_{\mathcal{K}_{l^*}}$ jointly bounded by 1
- $\mathbb{E}_P[(\mathcal{T}_P g)(Z)] = 0$ for all $g \in \mathcal{G}_{k,\|\cdot\|}$ under mild conditions [Gorham and Mackey, 2017]

Computing the Kernel Stein Discrepancy

Kernel Stein discrepancy (KSD) $S(Q_n, T_P, \mathcal{G}_{k, \|\cdot\|})$

• Stein operator $(\mathcal{T}_P g)(x) \triangleq \langle g(x), \nabla \log p(x) \rangle + \langle \nabla, g(x) \rangle$

• Stein set
$$\mathcal{G}_{k,\|\cdot\|} \triangleq \{g = (g_1, \dots, g_d) \mid \|v\|^* \le 1 \text{ for } v_j \triangleq \|g_j\|_{\mathcal{K}_k}\}$$

Benefit: Computable in closed form [Gorham and Mackey, 2017]

•
$$\mathcal{S}(Q_n, \mathcal{T}_P, \mathcal{G}_{k, \|\cdot\|}) = \|w\|$$
 for $w_j \triangleq \sqrt{\sum_{i, i'=1}^n k_0^j(x_i, x_{i'})}$.

• Reduces to parallelizable pairwise evaluations of Stein kernels

$$k_0^j(x,y) \triangleq \frac{1}{p(x)p(y)} \nabla_{x_j} \nabla_{y_j}(p(x)k(x,y)p(y))$$

- Stein set choice inspired by control functional kernels $k_0=\sum_{j=1}^d k_0^j$ of Oates, Girolami, and Chopin [2016]
- When $\|\cdot\| = \|\cdot\|_2$, recovers the KSD of Chwialkowski, Strathmann, and Gretton [2016], Liu, Lee, and Jordan [2016]
- To ease notation, will use $\mathcal{G}_k riangleq \mathcal{G}_{k,\|\cdot\|_2}$ in remainder of the talk

Detecting Non-convergence

Goal: Show $\mathcal{S}(Q_n, \mathcal{T}_P, \mathcal{G}_k) \to 0$ only if $(Q_n)_{n \ge 1}$ converges to P

- Let \mathcal{P} be the set of targets P with Lipschitz $\nabla \log p$ and distant strong log concavity $\left(\frac{\langle \nabla \log(p(x)/p(y)), y-x \rangle}{\|x-y\|_2^2} \ge k \text{ for } \|x-y\|_2 \ge r\right)$
 - Includes Gaussian mixtures with common covariance, Bayesian logistic and Student's t regression with Gaussian priors, ...
- For a different Stein set \mathcal{G} , Gorham, Duncan, Vollmer, and Mackey [2016] showed $(Q_n)_{n\geq 1}$ converges to P if $P \in \mathcal{P}$ and $\mathcal{S}(Q_n, \mathcal{T}_P, \mathcal{G}) \to 0$

New contribution [Gorham and Mackey, 2017]

Theorem (Univarite KSD detects non-convergence)

Suppose $P \in \mathcal{P}$ and $k(x, y) = \Phi(x - y)$ for $\Phi \in C^2$ with a non-vanishing generalized Fourier transform. If d = 1, then $\mathcal{S}(Q_n, \mathcal{T}_P, \mathcal{G}_k) \to 0$ only if $(Q_n)_{n \geq 1}$ converges weakly to P.

• Justifies use of KSD with Gaussian, Matérn, or inverse multiquadric kernels k in the univariate case

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Kernel Stein Discrepancy

The Importance of Kernel Choice

Goal: Show $\mathcal{S}(Q_n, \mathcal{T}_P, \mathcal{G}_k) \to 0$ only if Q_n converges to P

• In higher dimensions, KSDs based on common kernels fail to detect non-convergence, even for Gaussian targets *P*

Theorem (KSD fails with light kernel tails [Gorham and Mackey, 2017])

Suppose $d \ge 3$, $P = \mathcal{N}(0, I_d)$, and $\alpha \triangleq (\frac{1}{2} - \frac{1}{d})^{-1}$. If k(x, y) and its derivatives decay at a $o(||x - y||_2^{-\alpha})$ rate as $||x - y||_2 \to \infty$, then $\mathcal{S}(Q_n, \mathcal{T}_P, \mathcal{G}_k) \to 0$ for some $(Q_n)_{n\ge 1}$ not converging to P.

- Gaussian ($k(x,y) = e^{-\frac{1}{2} ||x-y||_2^2}$) and Matérn kernels fail for $d \geq 3$
- Inverse multiquadric kernels $(k(x,y) = (1 + ||x y||_2^2)^{\beta})$ with $\beta < -1$ fail for $d > \frac{2\beta}{1+\beta}$
- The violating sample sequences $(Q_n)_{n\geq 1}$ are simple to construct

Problem: Kernels with light tails ignore excess mass in the tails

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The Importance of Tightness

Goal: Show $\mathcal{S}(Q_n, \mathcal{T}_P, \mathcal{G}_k) \to 0$ only if Q_n converges to P

- A sequence $(Q_n)_{n\geq 1}$ is **uniformly tight** if for every $\epsilon > 0$, there is a finite number $R(\epsilon)$ such that $\sup_n Q_n(||X||_2 > R(\epsilon)) \leq \epsilon$
 - Intuitively, no mass in the sequence escapes to infinity

Theorem (KSD detects tight non-convergence [Gorham and Mackey, 2017])

Suppose that $P \in \mathcal{P}$ and $k(x, y) = \Phi(x - y)$ for $\Phi \in C^2$ with a non-vanishing generalized Fourier transform. If $(Q_n)_{n\geq 1}$ is uniformly tight and $\mathcal{S}(Q_n, \mathcal{T}_P, \mathcal{G}_k) \to 0$, then $(Q_n)_{n\geq 1}$ converges weakly to P.

 Good news, but, ideally, KSD would detect non-tight sequences automatically...

Detecting Non-convergence

Goal: Show $\mathcal{S}(Q_n, \mathcal{T}_P, \mathcal{G}_k) \to 0$ only if Q_n converges to P

• Consider the inverse multiquadric (IMQ) kernel

 $k(x,y)=(c^2+\|x-y\|_2^2)^\beta \ \text{for some} \ \beta<0, c\in\mathbb{R}.$

- IMQ KSD fails to detect non-convergence when $\beta < -1$
- \bullet However, IMQ KSD automatically enforces tightness and detects non-convergence when $\beta \in (-1,0)$

Theorem (IMQ KSD detects non-convergence [Gorham and Mackey, 2017])

Suppose $P \in \mathcal{P}$ and $k(x, y) = (c^2 + ||x - y||_2^2)^{\beta}$ for $\beta \in (-1, 0)$. If $\mathcal{S}(Q_n, \mathcal{T}_P, \mathcal{G}_k) \to 0$, then $(Q_n)_{n \geq 1}$ converges weakly to P.

- No extra assumptions on sample sequence $(Q_n)_{n\geq 1}$ needed
- Intuition: Slow decay rate of kernel \Rightarrow unbounded (coercive) test functions in $\mathcal{T}_P \mathcal{G}_k \Rightarrow$ non-tight sequences detected

Goal: Show $\mathcal{S}(Q_n, \mathcal{T}_P, \mathcal{G}_k) \to 0$ when Q_n converges to P

Proposition (KSD detects convergence [Gorham and Mackey, 2017])

If $k \in C_b^{(2,2)}$ and $\nabla \log p$ Lipschitz and square integrable under P, then $S(Q_n, \mathcal{T}_P, \mathcal{G}_k) \to 0$ whenever the Wasserstein distance $d_{\mathcal{W}_{\|\cdot\|_2}}(Q_n, P) \to 0.$

 $\bullet\,$ Covers Gaussian, Matérn, IMQ, and other common bounded kernels k

A Simple Example



sample Q_n from P and an i.i.d. sample Q'_n from one component

- Expect $\mathcal{S}(Q_{1:n}, \mathcal{T}_P, \mathcal{G}_k) \to 0$ & $\mathcal{S}(Q'_{1:n}, \mathcal{T}_P, \mathcal{G}_k) \not\to 0$
- Compare IMQ KSD ($\beta = -1/2, c = 1$) with Wasserstein distance Mackey (MSR) Kernel Stein Discrepancy June 25, 2018 17 / 31

A Simple Example



Right plot: For $n = 10^3$ sample points,

- (Top) Recovered optimal Stein functions g
- (Bottom) Associated test functions $h \triangleq \mathcal{T}_P g$ which best discriminate sample Q_n from target P

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The Importance of Kernel Choice



- Target $P = \mathcal{N}(0, I_d)$
- Off-target Q_n has all $\|x_i\|_2 \le 2n^{1/d}\log n$, $\|x_i x_j\|_2 \ge 2\log n$
- Gaussian and Matérn KSDs driven to 0 by an off-target sequence that does not converge to P
- IMQ KSD $(\beta = -\frac{1}{2}, c = 1) \text{ does }$ not have this deficiency

Target posterior density: $p(x) \propto \pi(x) \prod_{l=1}^{L} \pi(y_l \mid x)$

• Prior $\pi(x)$, Likelihood $\pi(y \mid x)$

Approximate slice sampling [DuBois, Korattikara, Welling, and Smyth, 2014]

- Approximate MCMC procedure designed for scalability
 - Uses random subset of datapoints to approximate each slice sampling step
 - Target ${\cal P}$ is not stationary distribution
- Tolerance parameter ϵ controls number of datapoints evaluated
 - ϵ too small \Rightarrow too few sample points generated
 - ϵ too large \Rightarrow sampling from very different distribution
 - Standard MCMC selection criteria like **effective sample size** (ESS) and asymptotic variance do not account for this bias

Selecting Sampler Hyperparameters

Setup [Welling and Teh, 2011]

- Consider the posterior distribution P induced by L datapoints y_l drawn i.i.d. from a Gaussian mixture likelihood $Y_l | X \stackrel{\text{iid}}{\sim} \frac{1}{2} \mathcal{N}(X_1, 2) + \frac{1}{2} \mathcal{N}(X_1 + X_2, 2)$ under Gaussian priors on the parameters $X \in \mathbb{R}^2$ $X_1 \sim \mathcal{N}(0, 10) \perp X_2 \sim \mathcal{N}(0, 1)$
 - Draw m = 100 datapoints y_l with parameters $(x_1, x_2) = (0, 1)$
 - Induces posterior with second mode at $(x_1, x_2) = (1, -1)$
- For range of parameters ϵ , run approximate slice sampling for 148000 datapoint likelihood evaluations and store resulting posterior sample Q_n
- Use minimum IMQ KSD ($\beta = -\frac{1}{2}, c = 1$) to select appropriate ϵ
 - Compare with standard MCMC parameter selection criterion, effective sample size (ESS), a measure of Markov chain autocorrelation
 - Compute median of diagnostic over 50 random sequences

Selecting Sampler Hyperparameters



- ESS maximized at tolerance $\epsilon = 10^{-1}$
- IMQ KSD minimized at tolerance $\epsilon = 10^{-2}$

Selecting Samplers

Target posterior density: $p(x) \propto \pi(x) \prod_{l=1}^{L} \pi(y_l \mid x)$

• Prior $\pi(x)$, Likelihood $\pi(y \mid x)$

Stochastic Gradient Fisher Scoring (SGFS)

[Ahn, Korattikara, and Welling, 2012]

- Approximate MCMC procedure designed for scalability
 - Approximates Metropolis-adjusted Langevin algorithm and continuous-time Langevin diffusion with preconditioner
 - Random subset of datapoints used to select each sample
 - No Metropolis-Hastings correction step
 - Target P is not stationary distribution
- Two variants
 - SGFS-f inverts a $d \times d$ matrix for each new sample point
 - SGFS-d inverts a diagonal matrix to reduce sampling time

Selecting Samplers

Setup

- MNIST handwritten digits [Ahn, Korattikara, and Welling, 2012]
 - $10000 \mbox{ images, } 51 \mbox{ features, binary label indicating whether image of a 7 or a <math display="inline">9$
- $\bullet\,$ Bayesian logistic regression posterior P
 - L independent observations $(y_l,v_l)\in\{1,-1\}\times\mathbb{R}^d$ with

$$\mathbb{P}(Y_l = 1 | v_l, X) = 1/(1 + \exp(-\langle v_l, X \rangle))$$

• Flat improper prior on the parameters $X \in \mathbb{R}^d$

- Use IMQ KSD ($\beta = -\frac{1}{2}, c = 1$) to compare SGFS-f to SGFS-d drawing 10^5 sample points and discarding first half as burn-in
- For external support, compare bivariate marginal means and 95% confidence ellipses with surrogate ground truth Hamiltonian Monte chain with 10^5 sample points [Ahn, Korattikara, and Welling, 2012]

Selecting Samplers



- Left: IMQ KSD quality comparison for SGFS Bayesian logistic regression (no surrogate ground truth used)
- **Right:** SGFS sample points $(n = 5 \times 10^4)$ with bivariate marginal means and 95% confidence ellipses (blue) that align best and worst with surrogate ground truth sample (red).
- Both suggest small speed-up of SGFS-d (0.0017s per sample vs. 0.0019s for SGFS-f) outweighed by loss in inferential accuracy

Beyond Sample Quality Comparison

Goodness-of-fit testing

- Chwialkowski, Strathmann, and Gretton [2016] used the KSD $\mathcal{S}(Q_n,\mathcal{T}_P,\mathcal{G}_k)$ to test whether a sample was drawn from a target distribution P(see also Liu, Lee, and Jordan [2016])
- Test with default Gaussian kernel k experienced considerable loss of power as the dimension d increased
- We recreate their experiment with IMQ kernel ($\beta = -\frac{1}{2}, c = 1$)
 - For n = 500, generate sample $(x_i)_{i=1}^n$ with $x_i = z_i + u_i e_1$ $z_i \stackrel{\text{iid}}{\sim} \mathcal{N}(0, I_d)$ and $u_i \stackrel{\text{iid}}{\sim} \mathsf{Unif}[0, 1]$. Target $P = \mathcal{N}(0, I_d)$.
 - Compare with standard normality test of Baringhaus and Henze [1988]

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Table: Mean power of multivariate normality tests across 400 simulations

	d=2	d=5	d=10	d=15	d=20	d=25
B&H	1.0	1.0	1.0	0.91	0.57	0.26
Gaussian	1.0	1.0	0.88	0.29	0.12	0.02
IMQ	1.0	1.0	1.0	1.0	1.0	1.0
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Improving sample quality

- Given sample points $(x_i)_{i=1}^n$, can minimize KSD $S(\tilde{Q}_n, \mathcal{T}_P, \mathcal{G}_k)$ over all weighted samples $\tilde{Q}_n = \sum_{i=1}^n q_n(x_i)\delta_{x_i}$ for q_n a probability mass function
- Liu and Lee [2016] do this with Gaussian kernel $k(x,y)=e^{-rac{1}{h}\|x-y\|_2^2}$
 - Bandwidth h set to median of the squared Euclidean distance between pairs of sample points
- We recreate their experiment with the IMQ kernel $k(x,y) = (1+\frac{1}{\hbar}\|x-y\|_2^2)^{-1/2}$

Improving Sample Quality



- MSE averaged over 500 simulations (± 2 standard errors)
- Target $P = \mathcal{N}(0, I_d)$
- Starting sample $Q_n = \frac{1}{n} \sum_{i=1}^n \delta_{x_i}$ for $x_i \stackrel{\text{iid}}{\sim} P$, n = 100.

Future Directions

Many opportunities for future development

- Improve KSD scalability while maintaining convergence control
 - Inexpensive approximations of kernel matrix [?]
 - Subsampling of likelihood terms in $\nabla \log p$
- Addressing other inferential tasks
 - Control variate design

[??Oates, Girolami, and Chopin, 2016]

- Variational inference [Liu and Wang, 2016, Liu and Feng, 2016]
- Training generative adversarial networks [Wang and Liu, 2016] and variational autoencoders [Pu, Gan, Henao, Li, Han, and Carin, 2017]
- S Exploring the impact of Stein operator choice
 - An infinite number of operators ${\cal T}$ characterize P
 - How is discrepancy impacted? How do we select the best \mathcal{T} ?
 - Thm: If $\nabla \log p$ bounded and $k \in C_0^{(1,1)}$, then $S(Q_n, \mathcal{T}_P, \mathcal{G}_k) \to 0$ for some $(Q_n)_{n \ge 1}$ not converging to P
 - Diffusion Stein operators $(\mathcal{T}g)(x) = \frac{1}{p(x)} \langle \nabla, p(x)m(x)g(x) \rangle$ of

Gorham, Duncan, Vollmer, and Mackey [2016] may be appropriate for heavy tails

References I

- S. Ahn, A. Korattikara, and M. Welling. Bayesian posterior sampling via stochastic gradient Fisher scoring. In Proc. 29th ICML, ICML'12, 2012.
- A. D. Barbour. Stein's method and Poisson process convergence. J. Appl. Probab., (Special Vol. 25A):175–184, 1988. ISSN 0021-9002. A celebration of applied probability.
- A. D. Barbour. Stein's method for diffusion approximations. Probab. Theory Related Fields, 84(3):297–322, 1990. ISSN 0178-8051. doi: 10.1007/BF01197887.
- L. Baringhaus and N. Henze. A consistent test for multivariate normality based on the empirical characteristic function. *Metrika*, 35(1):339–348, 1988.
- K. Chwialkowski, H. Strathmann, and A. Gretton. A kernel test of goodness of fit. In Proc. 33rd ICML, ICML, 2016.
- C. DuBois, A. Korattikara, M. Welling, and P. Smyth. Approximate slice sampling for Bayesian posterior inference. In Proc. 17th AISTATS, pages 185–193, 2014.
- J. Gorham and L. Mackey. Measuring sample quality with Stein's method. In C. Cortes, N. D. Lawrence, D. D. Lee, M. Sugiyama, and R. Garnett, editors, Adv. NIPS 28, pages 226–234. Curran Associates, Inc., 2015.
- J. Gorham and L. Mackey. Measuring sample quality with kernels. arXiv:1703.01717, Mar. 2017.
- J. Gorham, A. Duncan, S. Vollmer, and L. Mackey. Measuring sample quality with diffusions. arXiv:1611.06972, Nov. 2016.
- F. Götze. On the rate of convergence in the multivariate CLT. Ann. Probab., 19(2):724-739, 1991.
- A. Korattikara, Y. Chen, and M. Welling. Austerity in MCMC land: Cutting the Metropolis-Hastings budget. In Proc. of 31st ICML, ICML'14, 2014.
- Q. Liu and Y. Feng. Two methods for wild variational inference. arXiv preprint arXiv:1612.00081, 2016.
- Q. Liu and J. Lee. Black-box importance sampling. arXiv:1610.05247, Oct. 2016. To appear in AISTATS 2017.
- Q. Liu and D. Wang. Stein Variational Gradient Descent: A General Purpose Bayesian Inference Algorithm. arXiv:1608.04471, Aug. 2016.
- Q. Liu, J. Lee, and M. Jordan. A kernelized Stein discrepancy for goodness-of-fit tests. In Proc. of 33rd ICML, volume 48 of ICML, pages 276–284, 2016.
- L. Mackey and J. Gorham. Multivariate Stein factors for a class of strongly log-concave distributions. arXiv:1512.07392, 2015.
- A. Müller. Integral probability metrics and their generating classes of functions. Ann. Appl. Probab., 29(2):pp. 429-443, 1997.

- C. J. Oates, M. Girolami, and N. Chopin. Control functionals for Monte Carlo integration. Journal of the Royal Statistical Society: Series B (Statistical Methodology), pages n/a–n/a, 2016. ISSN 1467-9868. doi: 10.1111/rssb.12185.
- Y. Pu, Z. Gan, R. Henao, C. Li, S. Han, and L. Carin. Vae learning via stein variational gradient descent. In Advances in Neural Information Processing Systems, pages 4237–4246, 2017.
- C. Stein. A bound for the error in the normal approximation to the distribution of a sum of dependent random variables. In Proc. 6th Berkeley Symposium on Mathematical Statistics and Probability (Univ. California, Berkeley, Calif., 1970/1971), Vol. II: Probability theory, pages 583–602. Univ. California Press, Berkeley, Calif., 1972.
- C. Stein, P. Diaconis, S. Holmes, and G. Reinert. Use of exchangeable pairs in the analysis of simulations. In Stein's method: expository lectures and applications, volume 46 of IMS Lecture Notes Monogr. Ser., pages 1–26. Inst. Math. Statist., Beachwood, OH, 2004.
- D. Wang and Q. Liu. Learning to Draw Samples: With Application to Amortized MLE for Generative Adversarial Learning. arXiv:1611.01722, Nov. 2016.
- M. Welling and Y. Teh. Bayesian learning via stochastic gradient Langevin dynamics. In ICML, 2011.

Comparing Discrepancies



- Left: Samples drawn i.i.d. from either the bimodal Gaussian mixture target $p(x) \propto e^{-\frac{1}{2}(x+1.5)^2} + e^{-\frac{1}{2}(x-1.5)^2}$ or a single mixture component.
- **Right:** Discrepancy computation time using *d* cores in *d* dimensions.

Mackey (MSR)